

<b>Notice of References Cited</b>	Application/Control No. 10/082,315	Applicant(s)/Patent Under Reexamination FUKUOKA ET AL	
	Examiner Ngoc-Yen M. Nguyen	Art Unit 1754	Page 1 of 1

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	B	US-5,834,378	11-1998	Kurtz et al.	438/694
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**NON-PATENT DOCUMENTS**

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